

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>	
	10/644,961	LEE ET AL.	
	<b>Examiner</b> James O. Hansen	<b>Art Unit</b> 3637	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
312	406.2		
	401	7/20/07	Jah